

## SPI/QPI PSRAM

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### Specifications

- **Single Supply Voltage**
  - VDD=1.62 to 1.98V
- **Interface:** SPI/QPI with SDR mode
- **Performance:** Clock rate up to
  - 144MHz for 32 Bytes Wrapped Burst
  - 84MHz for Linear Burst operation
- **Organization:** 64Mb, 8M x 8bits
- **Addressable Bit Range:** A[22:0]
- **Page Size:** 1024 bytes
- **Refresh:** Self-managed
- **Operating Temperature Range**
  - -40°C to +85°C (standard range)
  - -40°C to +105°C (extended range)
- **Maximum Standby Current**
  - 300μA @ 105°C
  - 200μA @ 85°C
  - 100μA @ 25°C

### Features

- **50Ω Output Drive Strength LVCMOS.**
- **Linear Burst** (continuous) or **32 Bytes Wrapped Burst** via toggle command.
- **Linear Burst** is supported up to 84MHz and can cross page boundary as long as tCEM is met.
- **Software Reset.**

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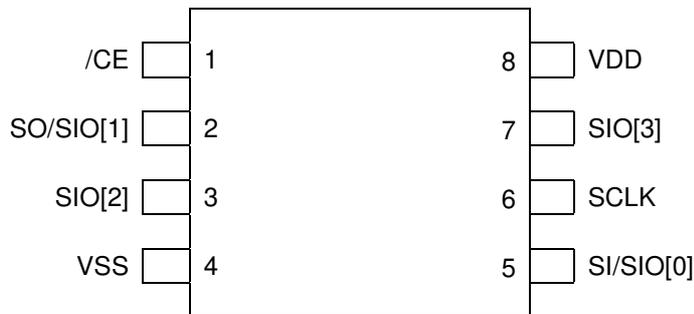
## 2 Introduction

This Pseudo-SRAM device features a high speed, low pin count interface. It has 4 SDR I/O pins and operates in SPI(serial peripheral interface) or QPI (quad peripheral interface) mode with frequencies up to 144 MHz. The data input (A/DQ) to the memory relies on clock (CLK) to latch all instructions, addresses and data. It is most suitable for low-power and low cost portable applications. It incorporates a seamless self-managed refresh mechanism. Hence it does not require the support of DRAM refresh from system host. The self-refresh feature is a special design to maximize performance of memory read operation.

## 3 Package Information

The APS6404L-SQR is available in standard package including 8-lead SOP-8L(150) and advanced package including 8-lead , USON-8L 3x2mm.

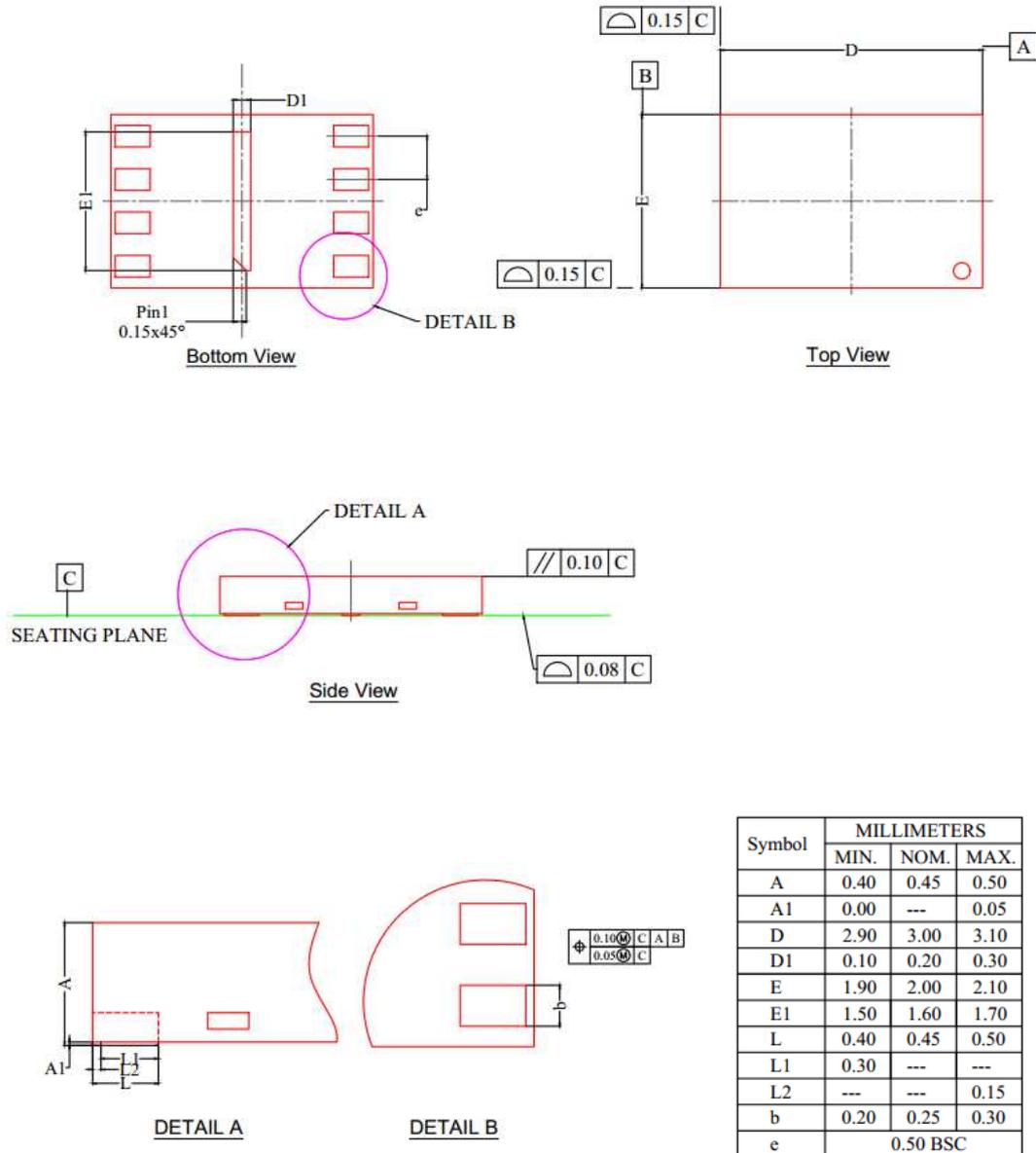
### 3.1 Package Types : SOP / USON (SN, ZR)



Top View



#### 4.2 USON-8L 3x2mm, package code ZR



**NOTE:**

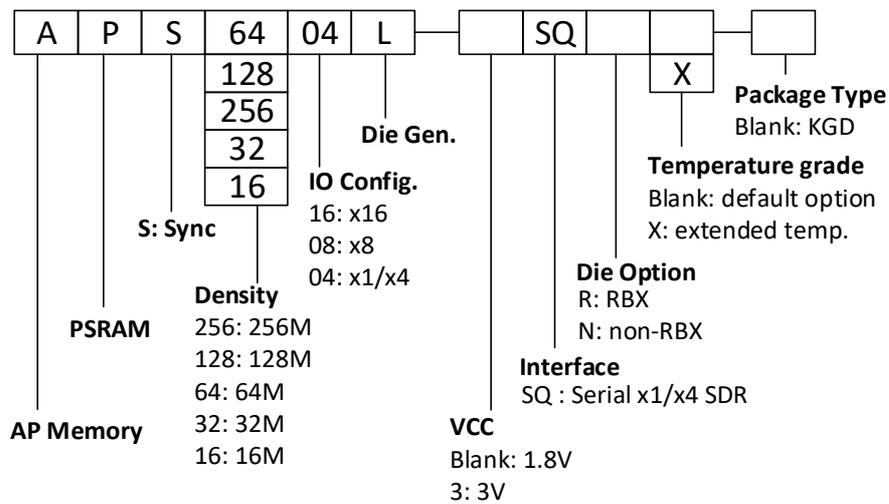
1. Scale 1:4
2. ALL DIMENSIONS AND TOLERANCES TAKE REFERENCE TO JEDEC MO-229
3. DIMENSION "b" APPLIES TO METALLIZED TERMINAL AND IS MEASURED BETWEEN 0.15MM AND 0.30MM FROM THE TERMINAL TIP. IF THE TERMINAL HAS OPTIONAL RADIUS ON THE OTHER END OF THE TERMINAL, THE DIMENSION B SHOULD NOT BE MEASURED IN THAT RADIUS AREA.

## 5 Ordering Information

Table 1: Ordering Information

Part Number	Temperature Range	Max Frequency	Note
APS6404L-SQR-ZR	Tc=-25°C to +85°C	144 MHz*	USON-8
APS6404L-SQR-SN	Tc=-40°C to +85°C	144 MHz*	SOP-8
APS6404L-SQRX-SN	Tc=-40°C to +105°C	144 MHz*	SOP-8

Note \*: 144MHz for 32 Bytes Wrapped Burst operation  
84MHz for Linear Burst operation with RBX (row boundary crossing)



## 6 Signal Table

All signals are listed in Table 2.

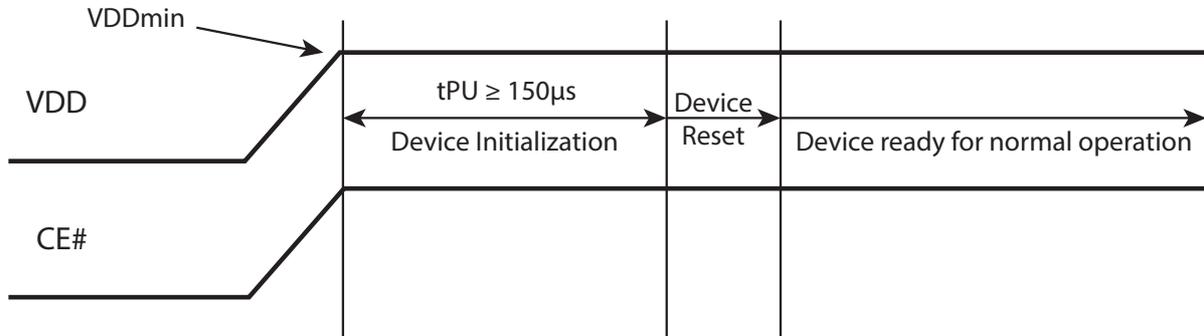
**Table 2: Signals Table**

Symbol	Type	SPI Mode Function	QPI Mode Function	Comments
VDD	Power	Core supply 1.8V		
VSS	Ground	Core supply ground		
CE#	Input	Chip select, active low. When CE#=1, chip is in standby state		
CLK	Input	Clock Signal		
SI/SIO[0]	IO	Serial Input	IO[0]	
SO/SIO[1]	IO	Serial Output	IO[1]	
SIO[2]	IO	--	IO[2]	
SIO[3]	IO	--	IO[3]	

## 7 Power-Up Initialization

SPI/QPI products include an on-chip voltage sensor used to start the self-initialization process. When VDD reaches a stable level at or above minimum VDD, the device will require 150 $\mu$ s and user-issued RESET Operation (see section 12) to complete its self-initialization process. From the beginning of power ramp to the end of the 150 $\mu$ s period, CLK should remain LOW, CE# should remain HIGH (track VDD within 200mV) and SI/SO/SIO[3:0] should remain LOW.

After the 150 $\mu$ s period the device is ready for normal operation.



**Figure 1. Power-Up Initialization Timing**

## 8 Interface Description

### 8.1 Address Space

SPI/QPI PSRAM device is byte-addressable. 64M device is addressed with A[22:0].

### 8.2 Page Size

Page size is 1K (CA[9:0]). Default burst setting is Linear Bursting that crosses page boundary in a continuous manner. Note however that burst operations which cross page boundary have a lower max input clock frequency of 84MHz, and it can cross page boundary one time only in a burst. Optionally the device can also be set to wrap 32 (CA[4:0]) via the Wrap Boundary Toggle command and is not allowed to cross page boundary in this configuration.

### 8.3 Drive Strength

The device powers up in 50Ω.

### 8.4 Power-on Status

The device powers up in SPI Mode. It is required to have CE# high before beginning any operations.

### 8.5 Command/Address Latching Truth Table

The device recognizes the following commands specified by the various input methods.

Command	Code	SPI Mode (QE=0)					QPI Mode (QE=1)				
		Cmd	Addr	Wait Cycle	DIO	Max Freq.	Cmd	Addr	Wait Cycle	DIO	Max Freq.
Read	'h03	S	S	0	S	33	N/A				
Fast Read	'h0B	S	S	8	S	144/84*	Q	Q	4	Q	66
Fast Read Quad	'hEB	S	Q	6	Q	144/84*	Q	Q	6	Q	144/84*
Write	'h02	S	S	0	S	144/84*	Q	Q	0	Q	144/84*
Quad Write	'h38	S	Q	0	Q	144/84*	same as 'h02				
Enter Quad Mode	'h35	S	-	-	-	144	N/A				
Exit Quad Mode	'hF5	N/A					Q	-	-	-	144
Reset Enable	'h66	S	-	-	-	144	Q	-	-	-	144
Reset	'h99	S	-	-	-	144	Q	-	-	-	144
Wrap Boundary Toggle	'hC0	S	-	-	-	144	Q	-	-	-	144
Read ID	'h9F	S	S	0	S	33	N/A				

Remark: S = Serial IO, Q = Quad IO

Note \*: **Max Freq.** would be 144MHz under Wrap32 operation; **Max Freq.** would be 84MHz under Linear Burst operation. Please refer Section 9 for Wrap32 and Linear Burst operation.

### 8.6 Command Termination

All Reads & Writes must be completed by raising CE# high immediately afterwards in order to terminate the active command and set the device into standby. Not doing so will block internal refresh operations and cause memory failure.

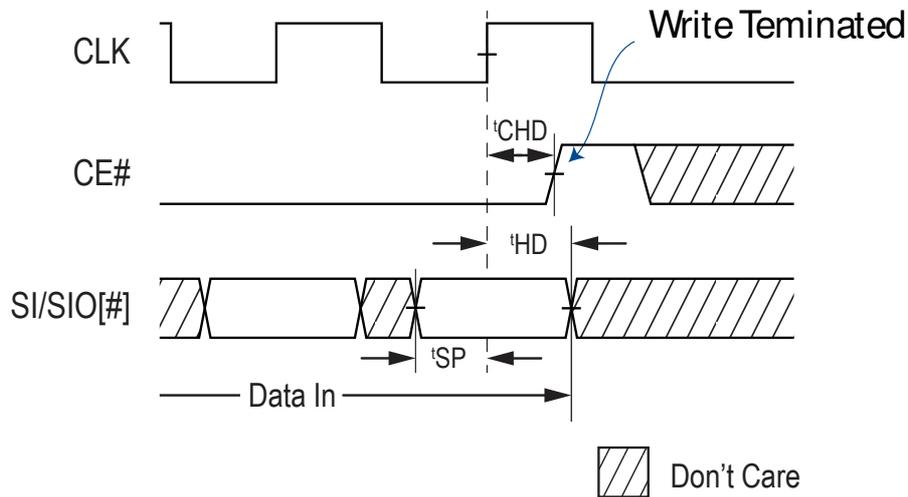


Figure 2: Write Command Termination

For a memory controller to correctly latch the last piece of data prior to read termination, it is recommended to provide a longer CE# hold time ( $t_{CHD} > t_{ACLK} + t_{CLK}$ ) for a sufficient data window.

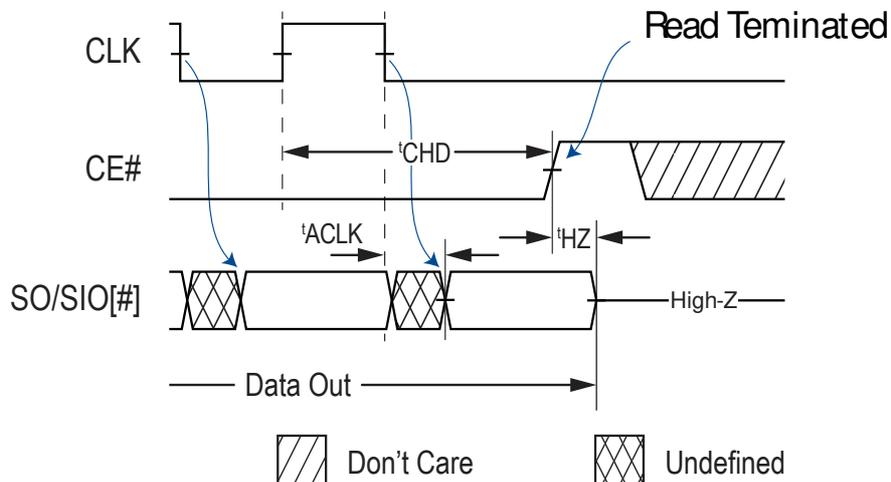


Figure 3: Read Command Termination

## 9 Wrap Boundary Toggle Operation

The Wrap Boundary Toggle Operation switches the device's wrapped boundary between Linear Burst which crosses the 1K page boundary (CA[9:0]) and wrap 32 (CA[4:0]) bytes. Default setting is Linear Burst.

Linear Burst allows the device to burst through page boundary. Page boundary crossing is invisible to the memory controller and limited to a lower max CLK frequency of 84MHz.

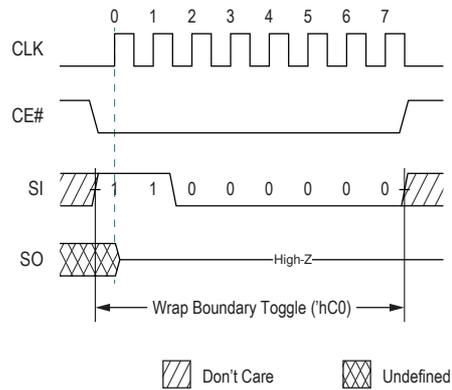


Figure 4: SPI Wrap Boundary Toggle 'hC0

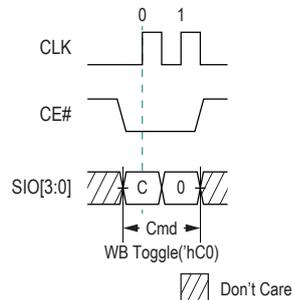


Figure 5: QPI Wrap Boundary Toggle 'hC0

Table 3: Wrapped Length:

Default	CMDs ('h03,'h0B,'hEB,'h02,'h38)	
Wrapped Length	Page Boundary Crossing enabled	Page Boundary Crossing disabled
Linear burst	Linear 1K cross page boundary	Wrap 1K
Wrap 32	Wrap 32	Wrap 32

## 10 SPI Mode Operations

The device powers up into SPI mode by default but can also be switched into QPI mode.

### 10.1 SPI Read Operations

For all reads, data will be available  $t^{\text{ACLK}}$  after the falling edge of CLK.

SPI Reads can be done in three ways with Linear Burst or 32 Bytes Wrapped Burst:

1. 'h03: Serial CMD, Serial Addr/IO, slow frequency,.
2. 'h0B: Serial CMD, Serial Addr/IO , fast frequency
3. 'hEB: Serial CMD, Quad Addr/IO , fast frequency

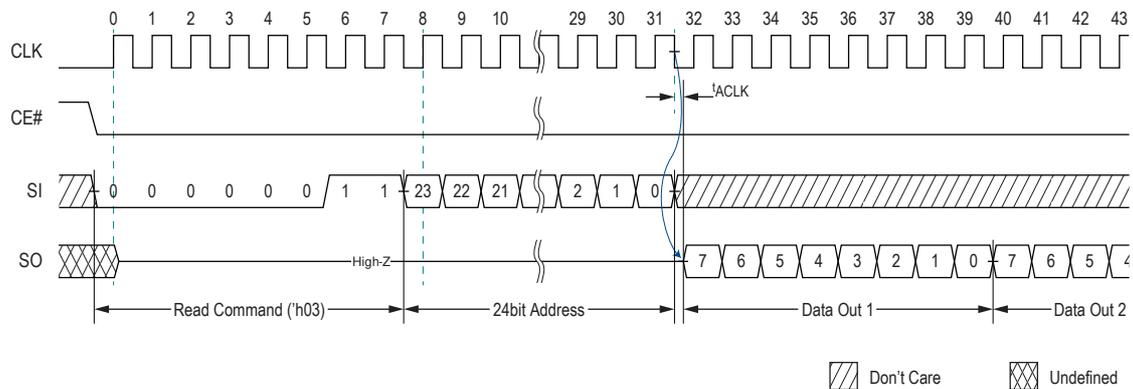


Figure 6: SPI Read 'h03 (max freq 33MHz)

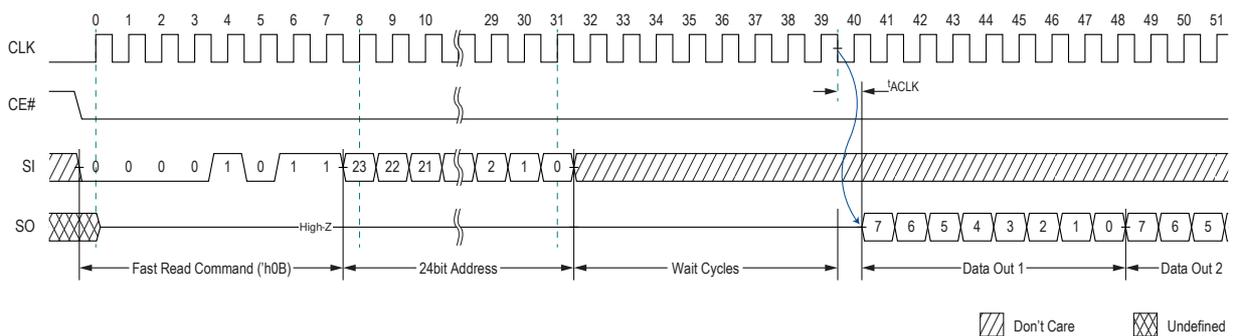


Figure 7: SPI Fast Read 'h0B (max freq 144 MHz)

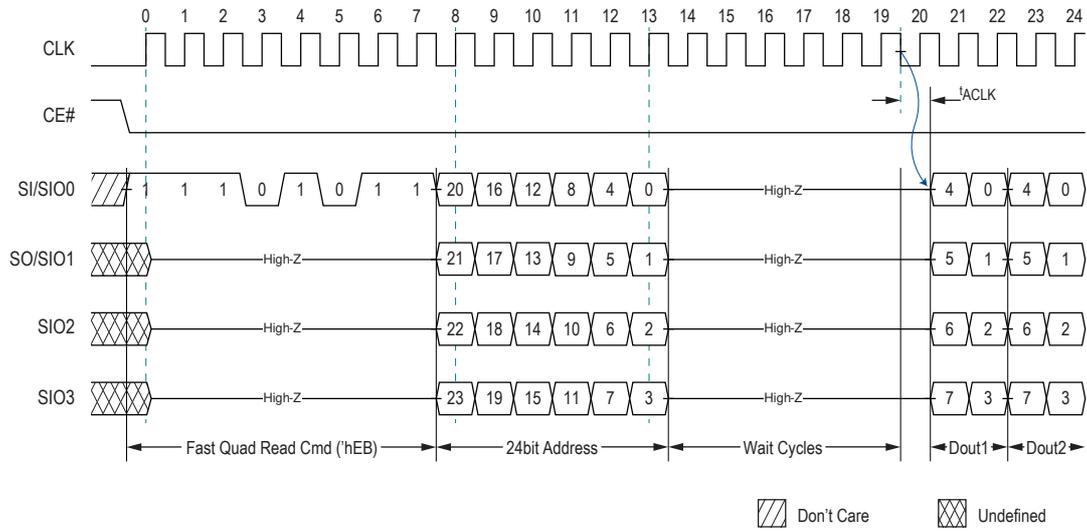


Figure 8: SPI Fast Quad Read 'hEB (max freq 144 MHz)

### 10.2 SPI Write Operations

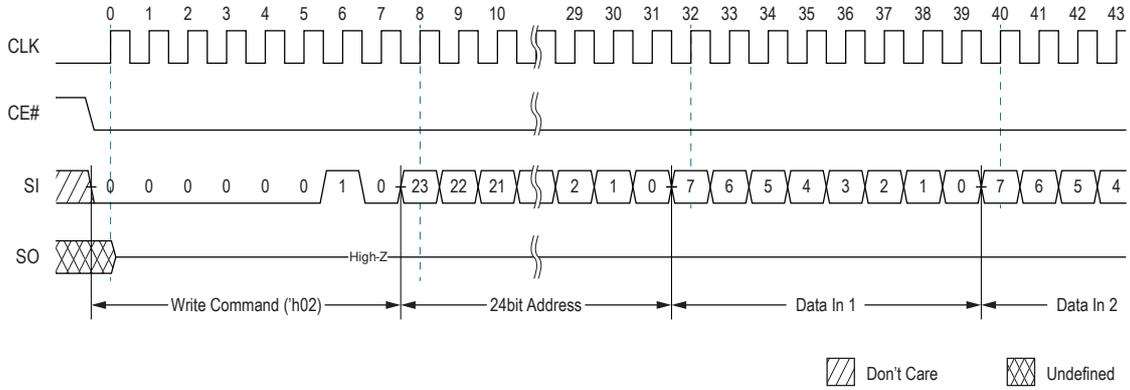


Figure 9: SPI Write 'h02

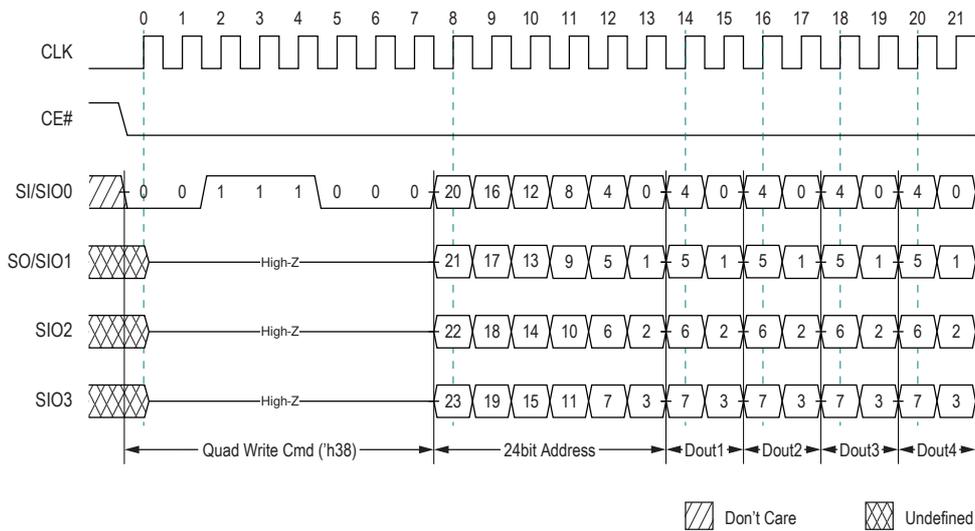


Figure 10: SPI Quad Write 'h38

### 10.3 SPI Quad Mode Enable Operation

This command switches the device into quad IO mode.

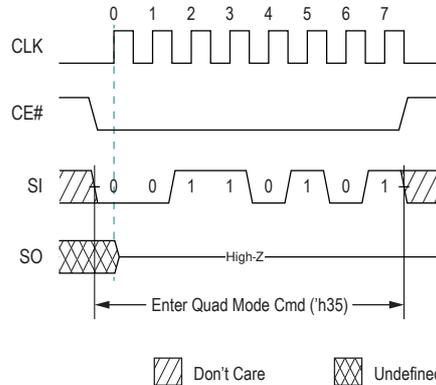


Figure 11: Quad Mode Enable 'h35 (available only in SPI mode)

### 10.4 SPI Read ID Operation

This command is similar to Fast Read, but without the wait cycles and the device outputs EID value instead of data.

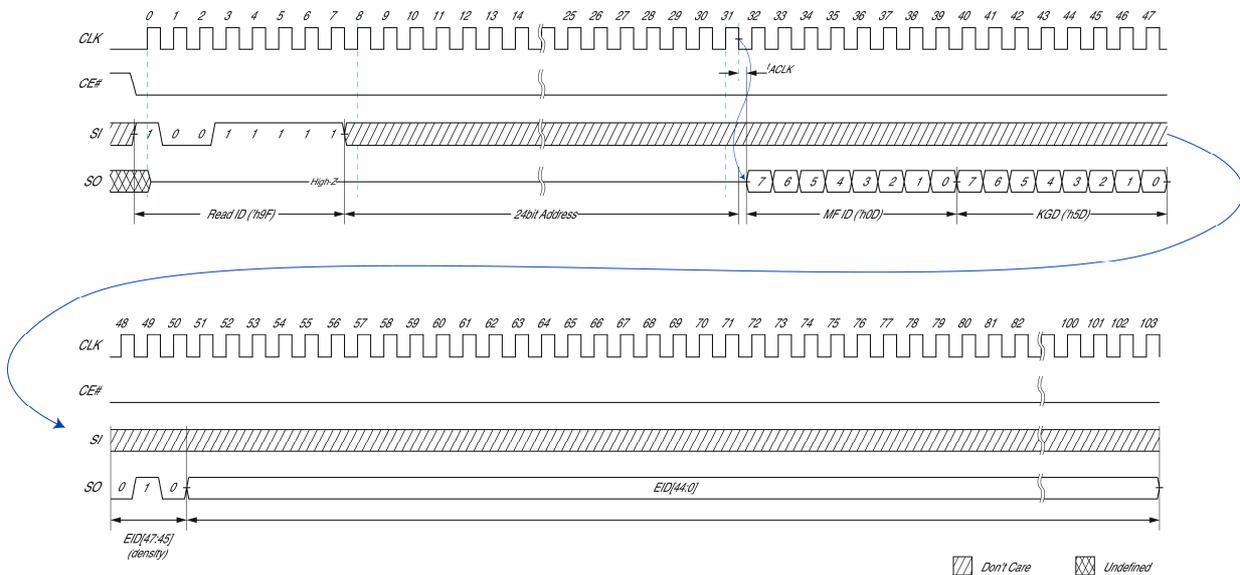


Figure 12: SPI Read ID 'h9F (available only in SPI mode)

Table 4: Known Good Die (KGD)

KGD[7:0]	Known Good Die
'b0101_0101	FAIL
'b0101_1101	PASS

\*Note: Default is FAIL die, and only mark PASS after all tests passed.

## 11 QPI Mode Operations

### 11.1 QPI Read Operation

For all reads, data will be available  $t^{\text{ACLK}}$  after the falling edge of CLK.

QPI Reads can be done in one of two ways with Linear Burst or 32 Bytes Wrapped Burst:

1. 'h0B: Quad CMD, Quad Addr/IO, slow frequency
2. 'hEB: Quad CMD, Quad Addr/IO, fast frequency

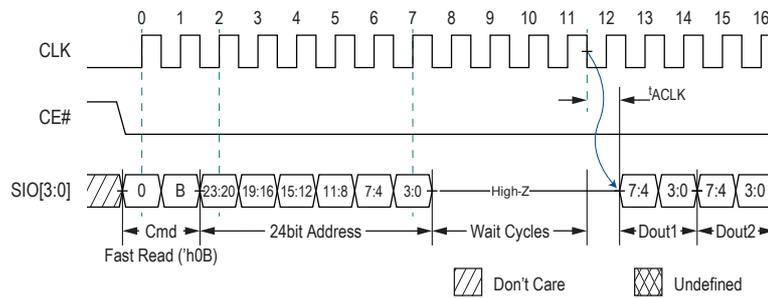


Figure 13: QPI Fast Read 'h0B (max freq 66 MHz)

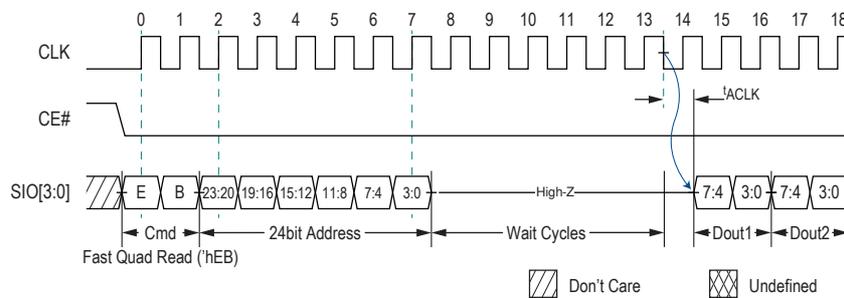


Figure 14: QPI Fast Quad Read 'hEB (max freq 144 MHz)

### 11.2 QPI Write Operation(s)

QPI write command can be input as 'h02 or 'h38.

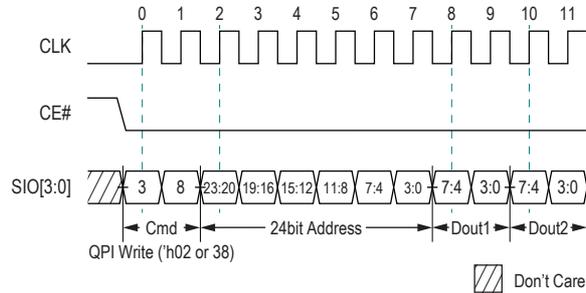


Figure 15: QPI Write 'h02 or 'h38

### 11.3 QPI Quad Mode Exit operation

This command will switch the device back into serial IO mode.

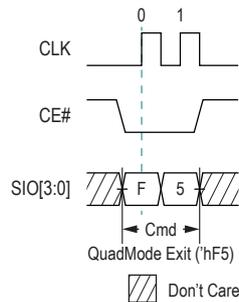


Figure 16: Quad Mode Exit 'hF5 (only available in QPI mode)

## 12 Reset Operation

The Reset operation is used as a system (software) reset that puts the device in SPI standby mode which is also the default mode after power-up. This operation consists of two commands: Reset-Enable (RSTEN) and Reset (RST).

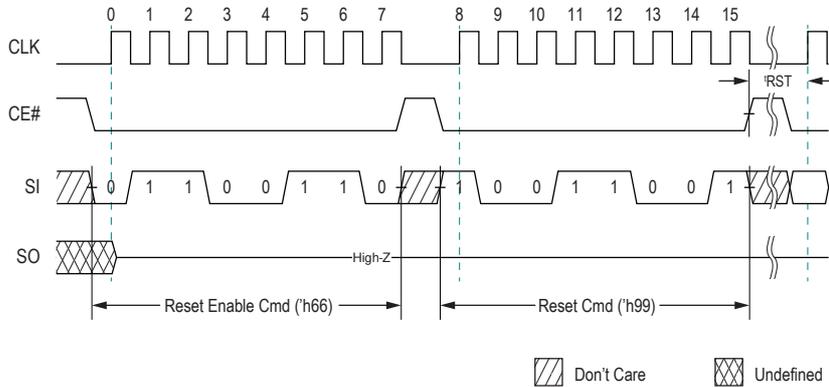


Figure 17: SPI Reset

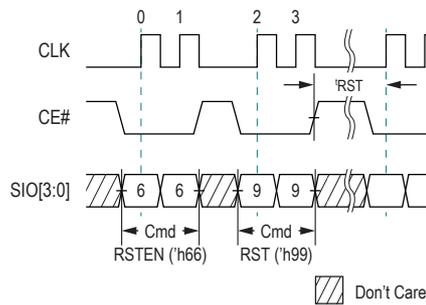


Figure 18: QPI Reset

Reset command has to immediately follow the Reset-Enable command in order for the reset operation to take effect. Any command other than the Reset command after the Reset-Enable command will cause the device to exit Reset-Enable state and abandon reset operation.

### 13 Input/Output Timing

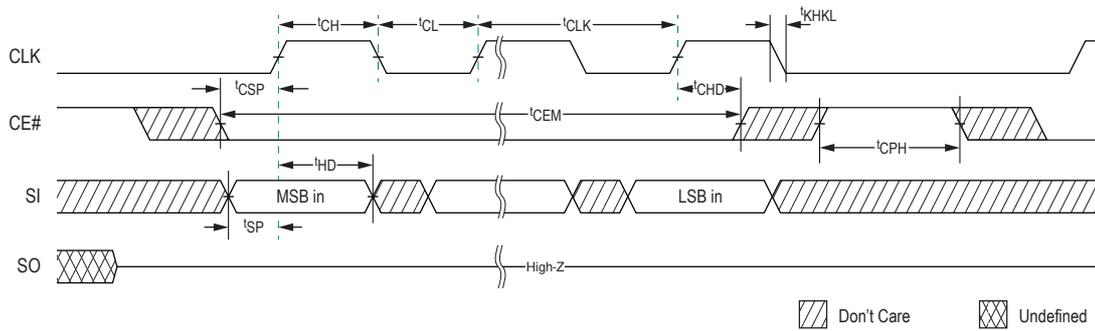


Figure 19: Input Timing

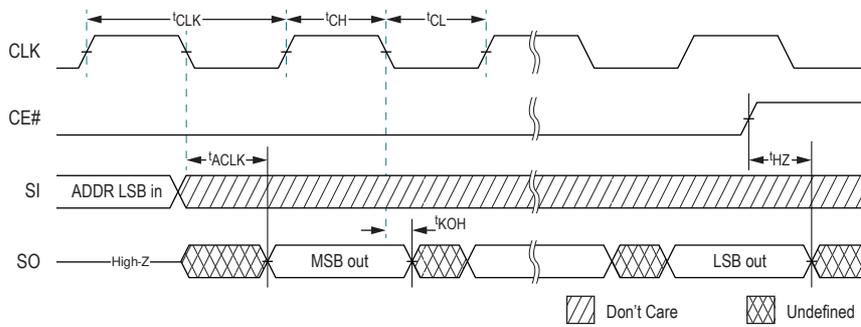


Figure 20: Output Timing

## 14 Electrical Specifications:

### 14.1 Absolute Maximum Ratings

Table 5: Absolute Maximum Ratings

Parameter	Symbol	Rating	Unit	Notes
Voltage to any ball except $V_{DD}$ relative to $V_{SS}$	VT	-0.4 to $V_{DD}+0.4$	V	
Voltage on $V_{DD}$ supply relative to $V_{SS}$	$V_{DD}$	-0.4 to +2.45	V	
Storage Temperature	$T_{STG}$	-55 to +150	°C	1

Notes 1: Storage temperature refers to the case surface temperature on the center/top side of the PSRAM.

Caution:

Exposing the device to stress above those listed in Absolute Maximum Ratings could cause permanent damage. The device is not meant to be operated under conditions outside the limits described in the operational section of this specification. Exposure to Absolute Maximum Rating conditions for extended periods may affect device reliability.

### 14.2 Pin Capacitance

Table 6: Bare Die Pin Capacitance

Parameter	Symbol	Min	Max	Unit	Notes
Input Pin Capacitance	CIN		2	pF	VIN=0V
Output Pin Capacitance	COUT		3	pF	VOUT=0V

Note 1: spec'd at 25°C.

Table 7: Package Pin Capacitance

Parameter	Symbol	Min	Max	Unit	Notes
Input Pin Capacitance	CIN		6	pF	VIN=0V
Output Pin Capacitance	COUT		8	pF	VOUT=0V

Note 1: spec'd at 25°C.

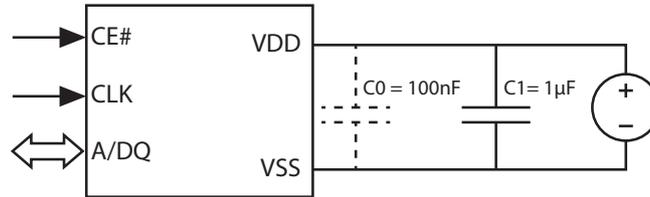
Table 8: Load Capacitance

Parameter	Symbol	Min	Max	Unit	Notes
Load Capacitance	$C_L$		15	pF	

Note 1: System  $C_L$  for the use of package

### 14.3 Decoupling Capacitor Requirement

It is required to have a decoupling capacitor on VDD pin for IO switchings and psram internal transient events. A low ESR 1 $\mu$ F ceramic cap is recommended. To minimize parasitic inductance, place the cap as close to VDD pin as possible. An optional 0.1 $\mu$ F can further improve high frequency transient response.



### 14.4 Operating Conditions

Table 9: Operating Characteristics

Parameter	Min	Max	Unit	Notes
Operating Temperature (extended)	-40	105	°C	1
Operating Temperature (standard)	-40(-25*)	85	°C	*varies by package

Note 1: spec'd temp range of -40 to 105°C is only characterized; test condition will be -32 to 105°C.

## 14.5 DC Characteristics

Table 10: DC Characteristics

Symbol	Parameter	Min	Max	Unit	Notes
V <sub>DD</sub>	Supply Voltage	1.62	1.98	V	
V <sub>IH</sub>	Input high voltage	V <sub>DD</sub> -0.4	V <sub>DD</sub> +0.2	V	
V <sub>IL</sub>	Input low voltage	-0.2	0.4	V	
V <sub>OH</sub>	Output high voltage (I <sub>OH</sub> =-0.2mA)	0.8 V <sub>DD</sub>		V	
V <sub>OL</sub>	Output low voltage (I <sub>OL</sub> =+0.2mA)		0.2 V <sub>DD</sub>	V	
I <sub>LI</sub>	Input leakage current		1	μA	
I <sub>LO</sub>	Output leakage current		1	μA	
I <sub>CC</sub>	Read/Write		7	mA	1,2
ISB <sub>EXT</sub>	Standby current (extended temp)		300	μA	3
ISB <sub>STD</sub>	Standby current (standard temp)		200	μA	3
ISB <sub>STDroom</sub>	Standby current (standard room temp)		100	μA	3,4

- Note
- 1: Output load current not included.
  - 2: Typical I<sub>CC</sub> 5.0mA at 144Mhz
  - 3: Standby current is measured when CLK is in DC low state.
  - 4: Typical ISB<sub>STDroom</sub> 66uA

## 14.6 AC Characteristics

Table 11: READ/WRITE Timing

Symbol	Parameter	Min	Max	Unit	Notes
t <sup>CLK</sup>	CLK period - SPI Read ('h03)	30.3		ns	33MHz
	CLK period - QPI Read ('h0B)	15.1			66MHz
	CLK period - all other operations	7			144MHz <sup>*1,2,3</sup>
t <sup>CH</sup> /t <sup>CL</sup>	Clock high/low width	0.45	0.55	t <sup>CLK</sup> (min)	
t <sup>KHKL</sup>	CLK rise or fall time		1.5	ns	4
t <sup>CPH</sup>	CE# HIGH between subsequent burst operations	18		ns	
t <sup>CEM</sup>	CE# low pulse width		4	μs	Extended grade
			8		Standard grade
t <sup>CSP</sup>	CE# setup time to CLK rising edge PKG	2.5		ns	
t <sup>CHD</sup>	CE# hold time from CLK rising edge PKG	3.0			2
t <sup>SP</sup>	Setup time to active CLK edge	2		ns	
t <sup>HD</sup>	Hold time from active CLK edge	2		ns	
t <sup>HZ</sup>	Chip disable to DQ output high-Z		5.5	ns	
t <sup>ACLK</sup>	CLK to output delay	2	5.5	ns	
t <sup>KOH</sup>	Data hold time from clock falling edge	1.5		ns	
t <sup>RST</sup>	Time between end of RST CMD to next valid CMD	50		ns	

Note 1: Only Linear Burst allows page boundary crossing. Frequency limits are therefore 144MHz for Wrap 32 Bytes, and 84MHz for Linear Burst commands cross page boundary

2: System max C<sub>L</sub> 15pF for the use of package.

3: For operating frequencies >84MHz, it is highly recommended to utilize CLK falling edge to sample read data or align sampling clock via data pattern tuning (refer to JEDEC JESD84-B50 for an example).

4: Measured from 20% to 80% of VDD

## 15 Change Log

Version	Date	Description
0.1	Dec 23, 2016	Initial Version
1.0	Mar 01, 2017	updated max frequency & standby current #
2.0	May 19, 2017	Reworded linear burst, renamed page toggle cmds; updated timing parameters for 144MHz; removed QPI Read 'h0B support; clarified termination section; added pin cap tables
2.1	Jul 10, 2017	Updated tCPH to 18ns
2.2	Jul 25, 2017	Updated tHZ, tACLK, package code and ordering information
2.3	Aug 24, 2017	Corrected package code; Added system max C <sub>L</sub> for the use of package & related tCK and tCHD
2.5	Oct 30, 2017	Enabled QPI Read 'h0B support; changed Min/Max absolute voltage, Vi <sub>L_min</sub> and Vih_max,; defined tCEM for different temperature grade; corrected speed typo. Added ISBstdroom & USON package ZR, ISBstd@25C
2.6	Nov 13, 2017	Modified spec of ICC, ISB
3.0	June 14, 2018	Revised part # for RBX. Temperature -40C, added WLCSP code "RA"
3.1	Aug 20, 2018	Revised WLCSP code "RA", max frequency for Read ID command, removed WSON
3.2	Nov 29, 2018	Revised POD of USON, code "ZR"
3.21	Mar 11, 2019	Removed 133MHz, modified ordering information and C Load
3.3	Sep 06, 2019	Updated Figure 12 and Table 10: DC Characteristics; Added table for Change Log; updated section 5, 8.5 and 14.6; added section 14.3
3.4a	Oct 02, 2019	Updated header, page 1 and Table 1
3.5	Oct 25, 2019	Revised the typo in Page 1, 12 and 16; updated Table 3 and Table 11, Figure 17 and Figure 18